TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74HC14AP,TC74HC14AF,TC74HC14AFN

Hex Schmitt Inverter

The TC74HC14A is a high speed CMOS SCHMITT INVERTER fabricated with silicon gate C²MOS technology.

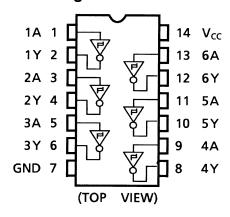
It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation. Pin configuration and function are the same as the TC74HC04A but the inputs have 25% VCC hysteresis and with its schmitt trigger function, the TC74HC14A can be used as a line receivers which will receive slow input signals.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

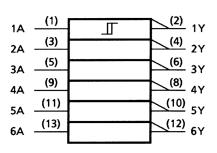
Features

- High speed: $t_{pd} = 11 \text{ ns (typ.)}$ at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 1 \mu A \text{ (max)}$ at $T_{a} = 25 \text{°C}$
- High noise immunity: $V_H = 1.1 \text{ V}$ at $V_{CC} = 5 \text{ V}$
- Output drive capability: 10 LSTTL loads
- Symmetrical output impedance: | IOH | = IOL = 4 mA (min)
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = $2\sim6$ V
- Pin and function compatible with 74LS14

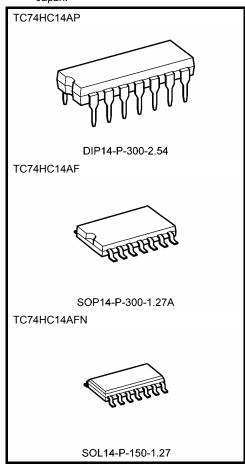
Pin Assignment



IEC Logic Symbol



Note: xxxAFN (JEDEC SOP) is not available in Japan.



Weight

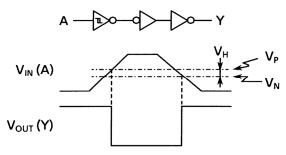
DIP14-P-300-2.54 : 0.96 g (typ.) SOP14-P-300-1.27A : 0.18 g (typ.) SOL14-P-150-1.27 : 0.12 g (typ.)



Truth Table

| Α | Υ |
|---|---|
| L | Н |
| Н | L |

System Diagram, Waveform



Absolute Maximum Ratings (Note 1)

| Characteristics | Symbol | Rating | Unit |
|------------------------------------|------------------|------------------------------|------|
| Supply voltage range | V _{CC} | -0.5~7 | V |
| DC input voltage | V _{IN} | -0.5~V _{CC} + 0.5 | ٧ |
| DC output voltage | V _{OUT} | -0.5~V _{CC} + 0.5 | V |
| Input diode current | I _{IK} | ±20 | mA |
| Output diode current | lok | ±20 | mA |
| DC output current | lout | ±25 | mA |
| DC V _{CC} /ground current | Icc | ±50 | mA |
| Power dissipation | PD | 500 (DIP) (Note 2)/180 (SOP) | mW |
| Storage temperature | T _{stg} | -65~150 | °C |

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of $Ta = -40^{\circ}C \sim 65^{\circ}C$. From $Ta = 65^{\circ}C$ to $85^{\circ}C$ a derating factor of -10 mW/°C shall be applied until 300 mW.

Operating Ranges (Note)

| Characteristics | Symbol | Rating | Unit |
|-----------------------|------------------|-------------------|------|
| Supply voltage | V _{CC} | 2~6 | V |
| Input voltage | V _{IN} | 0~V _{CC} | V |
| Output voltage | V _{OUT} | 0~V _{CC} | ٧ |
| Operating temperature | T _{opr} | -40~85 | °C |

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either VCC or GND.



Electrical Characteristics

DC Characteristics

| | | | Test Condition | | Ta = 25°C | | | Ta = -40~85°C | | |
|----------------------------|-----------------|--|--|---------------------|-----------|------|------|---------------|------|------|
| Characteristics | eristics Symbol | | | V _{CC} (V) | Min | Тур. | Max | Min | Max | Unit |
| | | | | | 1.0 | 1.25 | 1.50 | 1.0 | 1.50 | |
| Positive threshold voltage | V_{P} | | _ | 4.5 | 2.3 | 2.70 | 3.15 | 2.3 | 3.15 | V |
| | | | | 6.0 | 3.0 | 3.50 | 4.20 | 3.0 | 4.20 | |
| | | | | 2.0 | 0.30 | 0.65 | 0.9 | 0.30 | 0.9 | |
| Negative threshold voltage | V_N | | _ | 4.5 | 1.13 | 1.60 | 2.0 | 0.13 | 2.0 | V |
| | | | | 6.0 | 1.50 | 2.30 | 2.6 | 1.50 | 2.6 | |
| | | | | 2.0 | 0.3 | 0.6 | 1.0 | 0.3 | 1.0 | |
| Hysteresis voltage | V_{H} | _ | | 4.5 | 0.6 | 1.1 | 1.4 | 0.6 | 1.4 | V |
| | | | | 6.0 | 8.0 | 1.2 | 1.7 | 8.0 | 1.7 | |
| | V _{ОН} | V _{IN} = V _{IL} | | 2.0 | 1.9 | 2.0 | _ | 1.9 | _ | |
| | | | $I_{OH} = -20 \mu A$ | 4.5 | 4.4 | 4.5 | _ | 4.4 | _ | |
| High-level output voltage | | | | 6.0 | 5.9 | 6.0 | _ | 5.9 | | V |
| | | | $I_{OH} = -4 \text{ mA}$ | 4.5 | 4.18 | 4.31 | _ | 4.13 | _ | |
| | | $I_{OH} = -5.2 \text{ mA}$ | 6.0 | 5.68 | 5.80 | _ | 5.63 | | | |
| | | | | 2.0 | _ | 0.0 | 0.1 | _ | 0.1 | |
| | V _{OL} | V _{IN} = V _{IH} | $I_{OL} = 20 \mu A$ | 4.5 | _ | 0.0 | 0.1 | _ | 0.1 | |
| Low-level output voltage | | | | 6.0 | _ | 0.0 | 0.1 | _ | 0.1 | V |
| | | | I _{OL} = 4 mA | 4.5 | _ | 0.17 | 0.26 | _ | 0.33 | |
| | | | $I_{OL} = 5.2 \text{ mA}$ | 6.0 | _ | 0.18 | 0.26 | _ | 0.33 | |
| Input leakage current | I _{IN} | V _{IN} = V _{CC} or GND | | 6.0 | _ | _ | ±0.1 | _ | ±1.0 | μА |
| Quiescent supply current | Icc | V _{IN} = V _C | V _{IN} = V _{CC} or GND | | _ | _ | 1.0 | _ | 10.0 | μА |

AC Characteristics ($C_L = 15 \text{ pF}$, $V_{CC} = 5 \text{ V}$, $Ta = 25^{\circ}\text{C}$, input: $t_r = t_f = 6 \text{ ns}$)

| Characteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|------------------------|--------------------------------------|----------------|-----|------|----------|------|
| Output transition time | t _{TLH} t _{THL} | _ | _ | 4 | 8 | ns |
| Propagation delay time | t _{pLH} | | | 11 | 21 | no |
| | t _{pHL} | | | 11 | <u> </u> | ns |



AC Characteristics ($C_L = 50 \text{ pF}$, input: $t_r = t_f = 6 \text{ ns}$)

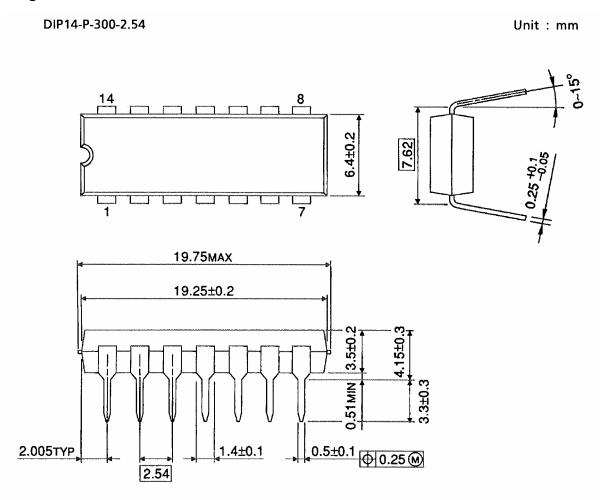
| Characteristics Symbol | | Test Condition | | Ta = 25°C | | | Ta = -4 | | |
|------------------------|------------------|---------------------|-----|-----------|-----|-----|---------|------|----|
| | | V _{CC} (V) | Min | Тур. | Max | Min | Max | Unit | |
| | 4 | | 2.0 | _ | 30 | 75 | _ | 95 | |
| Output transition time | t _{TLH} | _ | 4.5 | _ | 8 | 15 | _ | 19 | ns |
| | t _{THL} | | 6.0 | _ | 7 | 13 | _ | 16 | |
| time | | | 2.0 | _ | 42 | 125 | _ | 155 | |
| | | t _{pLH} | 4.5 | _ | 14 | 25 | _ | 31 | ns |
| | t _{pHL} | | 6.0 | _ | 12 | 21 | _ | 26 | |
| Input capacitance | C _{IN} | _ | | _ | 5 | 10 | _ | 10 | pF |
| Power dissipation | C _{PD} | | | | 28 | | | | pF |
| capacitance | (Note) | _ | | | 20 | | | | ρι |

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 I_{CC} (opr) = $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/6$ (per gate)

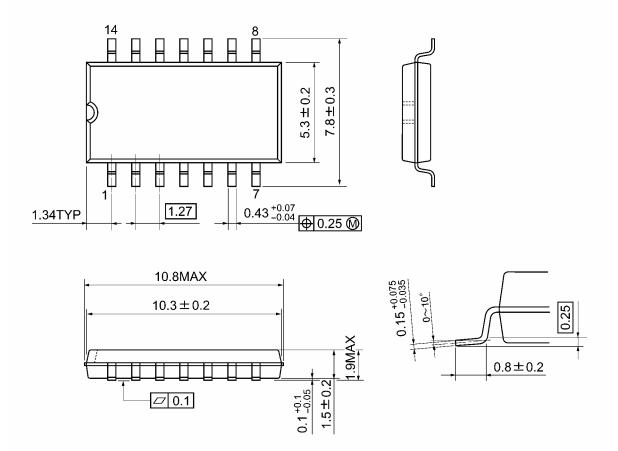
Package Dimensions



Weight: 0.96 g (typ.)

Package Dimensions

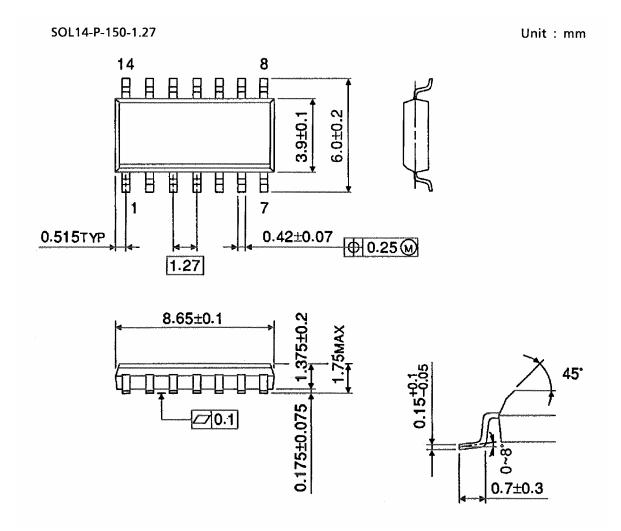
SOP14-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)



Package Dimensions (Note)



Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

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20070701-EN GENERAL

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